INFORMATION DISCLOSURE CITATION

(Use several sheets if necessary)

ATTY. DOCKET NO.	SERIAL NO.
1035-660	10/593,695

APPLICANT

Yasuhiko NAKASHIMA

FILING DATE	GROUP
September 20, 2006	2183

OPAP SEP 2 0 2010 — PATENT & TRADEMARK OFFICE (stamp)

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*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	2008/0250232	10-9-2008	Yasuhiko NAKASHIMA (corresponds to JP 2005-284683)			
	2002/0152368	10-17-2002	Tomohiro NAKAMURA (corresponds to JP 2002-312162)			

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*Examiner	/Idriss Alrobaye/	Date Considered	12/22/2010

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